Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/781,824	CHOI, CHANG-JUN		
Examiner	Art Unit		
Tan V. Mai	2193		

SEARCHED					
Class	Subclass	Date	Examiner		
updated	search	1/16/2008	MAI		
	:				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
708	712, 714	1/16/2008	MAI	
interfere	nt search (see nce search ntout)	1/16/2008	MAI	

SEARCH NO (INCLUDING SEARC		)
	DATE	EXMR
Updated search (see printout)	1/16/2008	MAI
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